

**Notice of References Cited**

Application/Control No.

10/525,668

Applicant(s)/Patent Under  
Reexamination  
HAECKER ET AL.

Examiner

CHRISTINE T. MUI

Art Unit

1797

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*	B	US-2002/0081222	06-2002	Karp, Christoph D.	417/507
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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